

<b>Notice of References Cited</b>	Application/Control No. 10/726,075		Applicant(s)/Patent Under Reexamination TAI ET AL.	
	Examiner Phillip H. Nguyen		Art Unit 2191	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,898,751	05-2005	Aikawa et al.	714/748
*	B	US-6,145,045	11-2000	Falik et al.	710/310
*	C	US-6,357,021	03-2002	Kitagawa et al.	714/41
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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